

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10/081,345	KARPF ET AL.	
Examiner	Art Unit	Devesh Khare	Page 1 of 1

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D	US-			
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L	US-			
M	US-			

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*	U	Auge et al. Tetrahedron Letters, 37(43), pp 7715-7716, 1996.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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